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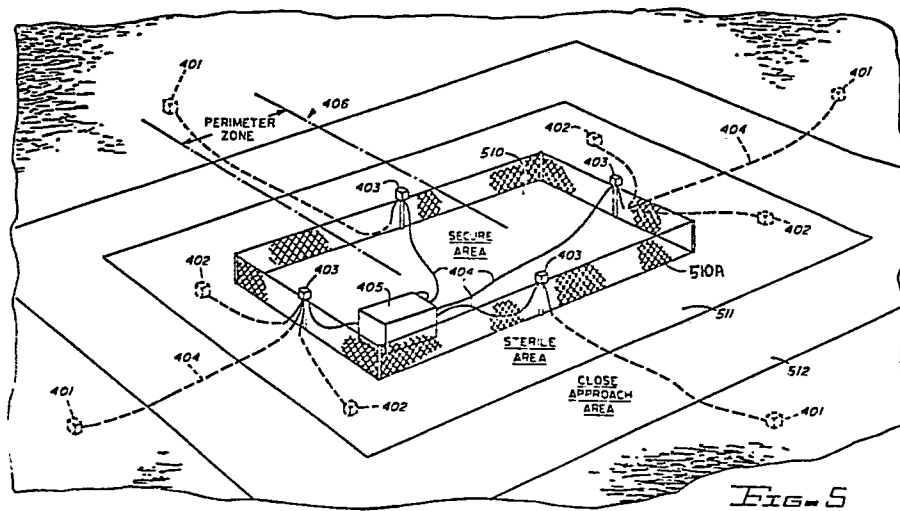
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54 **Perimeter security system.**

57 A system is provided for locating and for characterising the source of attempted and/or actual penetration of the security perimeters of relatively large geographical areas. The system comprises an array of structural moment detectors (401, 402, 403) and electronic circuitry (405) for processing and manipulating signals derived from the detectors (401, 402, 403) in such a manner as to produce secondary signals indicative of any seismic forces caused by a penetration of the security perimeter, the effect of extraneous seismic forces being excluded. In one embodiment, the electronic circuitry (405) associated with each structural moment detector (401, 403) is provided in the same housing as the detector to form a unitary device termed a structural information detector.



PERIMETER SECURITY SYSTEM

This invention relates to perimeter security systems for locating and characterising the source of attempted and/or actual penetration of the security perimeters of relatively large geographical areas; more particularly, the invention relates to such systems employing structural moment detectors.

Structural moment detectors or flexural rigidity sensors are known which are constituted by optical sensors in the form of autocollimators insensitive to linear dynamic motion but responsive to angular deflection of one end of the sensor with respect to the other. For example, such sensors are disclosed in the patent to Rossire, U.S. No. 3,229,511 and in the publication entitled "The Structural Rigidity Sensor: Applications in Non-Destructive Testing", published by the Air Force Systems Command, United States Air Force (Frank J. Seiler Research Laboratory, Publication SRL-TR-75-0017, October, 1975). See also the U.S. patents to Okubo Nos. 4,159,422 issued June 26, 1979 and 4,164,149 issued August 14, 1979.

Systems which employ structural moment detectors to measure and record certain effects of forces acting on a structure are also disclosed in the publications described above. For example, the Rossire patent discloses an aircraft attitude control system in which a structural moment detector is used to sense wing loading and automatically adjust the attitude of the aircraft to maintain wing loading within safe operational limits.

It is an object of the present invention to provide an improved perimeter security system utilising structural moment detectors.

Accordingly, the present invention provides a perimeter security system for locating and characterising the source of attempted and/or actual penetration of

relatively large geographical areas,
characterised in that said system comprises,
in combination:

- 5 a) a plurality of structural moment detectors
 arranged at spaced points in ground contact
 to detect intrusions and activities
 within and near the perimeter of said area;
- 10 b) processing means for processing said
 output signals to modify the information
 content thereof, including rejecting
 components of said signals indicative of
 the effects of extraneous seismic forces
 caused by other than said intrusions
 and/or activities; and
- 15 c) signal-manipulating means for manipulating
 the processed signals output by the processing
 means to provide secondary signals responsive
 to seismic forces caused by said intrusions
 and/or activities.

20 The systems of the invention can employ
substantially conventional structural moment detectors,
the output of which is simply raw data which does not
directly indicate or give useful information concerning
the effect of forces acting on a structure to which the
25 sensor is attached. In such cases, the raw data
from the sensors is conditioned and processed by
external electronics, including microprocessors and
computational software, usually necessarily located
at locations remote from the sensors themselves.

30 Alternatively the systems of the invention can
employ structural information detectors in which the
raw signal from the optical sensor of an optical
structural moment detector is converted and processed
within a unitary device (either a single-piece device
35 or a multi-component device in which each of the
components is assembled to form an integral unit)
such that the electrical signal output of the

device has a directly useful information content which can be displayed or recorded by any conventional means or which can be directly utilized to activate control systems.

5 The term "surface coordinate vector" as used herein is intended to mean both the normal and the tangent to the surface of a structure and any angle therebetween.

10 The invention will now be particularly described, by way of example, with reference to the accompanying diagrammatic drawings, in which:

Fig. 1 is a sectional view of a typical prior art structural moment detector;

15 Fig. 2 is a typical schematic of the LED driver circuit of the structural moment detector of Fig. 1;

Fig. 3 is a typical schematic of the readout electronics circuits of the structural moment detector of Fig. 1:

20 Fig. 4 is a schematic drawing of a monitoring system embodying the invention;

Fig. 5 is a schematic perspective view of a perimeter security system utilising the monitoring system of Fig. 4.

Fig. 6 is a generalised block diagram illustrating the major sub-components of a structural information detector suitable for use in the systems of Figures 4 and 5;

5 Fig. 7 is a circuit schematic depicting an analog circuit which functions to electrically interface the optical detector of the structural information detector of Figure 6 with signal-processing electronics;

10 Fig. 8 is a circuit schematic depicting the current source circuit for light-emitting diodes of the optical sensor portion of the Figure 6 structural information detector;

15 Fig. 9 is a sectional view of one particular form of the Figure 6 structural information detector;

 Fig. 10 is a perspective view of another particular form of the Figure 6 structural information detector in which the components are carried by a semiconductor substrate; and

20 Fig 11 is a perspective view of an optical system usable in the Figure 6 structural information detector as well as in the structural moment detectors or flexural rigidity sensors of the prior art.

25 As used herein, the term "structural moment detector" means a device which measures the integral of the structure moment between two points on the structure. Such devices are known in the art, but, for clarity, a typical structural moment detector will be briefly described with reference to

Figs. 1-3 and the accompanying descriptive material.

The structural moment detector shown in Figure 1 is basically an autocollimator that is insensitive to linear dynamic motions but responds to angular deflection of one end of the sensor with respect to the other. The structural moment detector illustrated consists of two separate parts which are mounted at spaced locations on a beam 10. One of the parts 11 is a support bracket 12 which carries a light-emitting diode (LED) 13, a collimating lens 14 and dual photovoltaic detectors 15. The other part 16 of the structural moment detector consists of a support bracket 17 which carries a plane front mirror 18. The two parts 11 and 16 are suitably joined by a bellows or other hood member (omitted for clarity of illustration) to exclude extraneous light. The LED 13 emits an infrared light beam 19 which is collimated by the collimating lens 14. The collimated light beam 19a impinges on the mirror 18 and, as indicated by the dashed lines 10, is reflected back through the collimating lens 14 to the photovoltaic cells 15. Angular motions, but not linear motions, of the mirror 18 result in varying amounts of infrared radiation reaching each of the photovoltaic cells 15. The difference in voltage output of the photovoltaic cells 15 is then proportional to the angular motion of the mirror 18 with respect to the cells 15.

Structural moment detectors of the Figure 1 form are capable of measuring the deflection of the beam with a resolution of 1 milliarc second (4.85×10^{-9} radians) with a range of ± 6 arc seconds. Where such accuracy is not required, such devices can be fabricated which have a resolution of at least 1 arc second with a dynamic range of $\pm 3^0$. Such devices are capable of operating from DC to 50 MHz, the upper limit being established by the frequency limitation of the

photovoltaic cells.

Typical circuits which are used in conjunction with the mechanical components of the structural moment detector of Fig. 1 are illustrated in Figs.

5 2 and 3. Fig. 2 is a schematic diagram of a suitable LED driver circuit which is a simple constant current source circuit which is required to provide a light source with constant light intensity. A typical suitable readout circuit is illustrated in Fig. 3,
10 which depicts an analog output circuit consisting of a first stage amplifier with common mode rejection that permits linear operation of the photovoltaic cells.

The operation of the structural moment detector can be illustrated by reference to a simplified
15 example of a cantilevered beam which is loaded and the structural moment detector is mounted at points a and b located near the supported end of the cantilevered beam. If the deflection of the beam is measured as θ , the angle between surface tangents
20 at points a and b, the output voltage of the photovoltaic cells is proportional to this angle, and according to the Area Moment Theorem

$$25 \quad V_{out} \propto \frac{\int_a^b M dx}{EI} = \frac{1}{EI} \int_a^b M dx$$

where

M is the applied moment between points a and b

E is the modulus of elasticity

I is the moment of inertia

30 θ is the angular difference between surface tangents at points a and b

x is the linear surface distance between points a and b.

If a load P is placed on the end of a beam of
35 length L and is the distance between points a and b,

then

$$V_{out} \propto \theta = \frac{1}{EI} \frac{PL \delta}{2}$$

To illustrate the sensitivity of the structural moment detector, a load of 1 gram was placed at the end of an 8" cantilevered beam. The device was mounted near the support of the beam such that points a and b were 1.5" apart. With this load

$$V_{out} = 30 \text{ millivolts}$$

and

$$\theta = 1.3 \times 10^{-7} \text{ radians.}$$

Since it is impossible to load a structure without changing the total moment which occurs between two points on the structure, it is possible to use the structural moment detector as an extremely accurate and extremely sensitive sensor having a range which far exceeds that of conventional sensors of the prior art.

The general system of the invention is schematically illustrated in Fig. 4. As shown in Fig. 4, the structural behaviour 41, which is effected by the forces acting on the structure, are sensed by an array 42 of structural moment detectors (SMD's), located on the structure. The SMD's 42 are located on the structure so as to provide primary electronic signals 43 which are proportional to the structural behaviour parameter of interest. The primary electronic signals 43 from the SMD array 42 are fed to signal processing and buffering equipment 44, which includes electronic circuitry which modifies the information content of the primary signals 43 (e.g., rejection of background noise, rejection of signal components induced by other forces, etc.) and which electrically isolate the



sensors from the remainder of the system. The processed signals 45 are then transmitted to analog-to-digital converters 46 which convert the analog information in the processed signals 45 to a digital format compatible with various digital processors, recorders, editors and/or display units. The digital signals 47 are then transmitted to a data processor 48 which will usually be a single-frame computer which is capable of accepting digital data and manipulating it in a predetermined, programmable fashion, in order to convert the digitized measurement information into a digital representation of the desired system data. The digital representation data 49 is optionally transmitted to data recording/editing equipment 50 which may provide for permanent recording of all or part of the acquired data for later use and which may, additionally, provide manual editing capability. The recorded and/or edited data 51 may optionally be transmitted to data display equipment 52 which provides visual display of the acquired data and, additionally, may provide for the predetermined alteration of the means by which the data processing equipment 48 is transforming acquired data or the manner in which data is digitized, recorded, edited and/or displayed. Feedback loops 53 may be optionally provided, through which the information at one stage is fed backwardly and/or forwardly to another stage of the system to provide improved accuracy, estimation, prediction or other similar functions. These feedback paths may be electrical, optical, mechanical and/or may involve human interpretations and adjustments.



According to this invention, systems are provided for detecting, warning of and characterising the source of intrusions of the security perimeters of relatively large geographical areas.

5 The extreme sensitivity of the SMD provides a seismic detector and the invention incorporates such a detector into a system which is capable of providing information on type, number, location, and movement of enemy forces.

10 The SMD is mounted on a diaphragm and used as a geophone. The sensitivity of the SMD coupled with the variable design parameters (material, thickness, size, mounting technique) of the diaphragm produce a geophone of remarkable
15 performance.

When suitably deployed, any motion near the sensor produces a characteristic vibration signature. The existence of the signal is used to indicate movement and the frequency content is
20 analyzed to provide information about the source. Using triangulation techniques and/or proximity to various sensors, the location and direction of movement can be determined.

The system is capable of detecting and monitoring
25 movement on the ground or in below-ground tunnels. Sensors can be hardwired to processing equipment or can be self-contained battery powered units which communicate optically or electronically with monitoring stations and/or aircraft.

30 Figure 5 depicts a perimeter security system utilising the Figure 4 monitoring system. The perimeter security system can be utilised to protect large geographical areas such as private estates, industrial plants, oilfields, airfields, communications
35 installations and, in fact, any geographical area



which is required to be protected against unauthorised entry.

The perimeter security system, according to the presently preferred embodiment of the invention,
5 functions to warn against unauthorised entry into the secure area 510 and, further, to give preliminary warnings of unauthorised entry or activity within a so-called "sterile area" 511 and entry or activity in a close approach area 512. A plurality of SMD's 401
10 arte buried in the ground at spaced locations outside the close approach area 512. Other SMD's 402 are buried in the ground within the sterile area 511 and additional SMD's 403 are located on the posts of a fence 510A around the sterile area. The SMD's 401,
15 402 and 403 are linked by appropriate cables 404 to one or more command centres 405, located within the secure area 510, which houses the required electronics, microprocessors, software, etc.

By triangulation techniques, the unauthorised entry
20 or activity can be identified and located as being within any one of a plurality of perimeter zones 406 which are segments of the perimeters of the secure area 510, sterile area 511 and close approach area 512.

The perimeter security system of the invention
25 provides for identification or characterisation of the entrant or activity, location of the penetration and of approach to the security perimeters as well as providing a system for communication among the various areas of interest. The perimeter security system may be applied
30 to protect areas having widely varying geographical conditions such as deserts, swamps, urban areas and the like, with low level maintenance and operating costs and capabilities. The components of the systems may be easily transported to remote sites across
35 rough terrain and the system has very low system-originated disturbance false alarms and system failure false alarms.

Unauthorised entry of activity within the close approach area 512 initiates a warning signal at the control centre 405 and entry into the sterile or secure area initiates appropriate responses such as
5 activation of specific security systems, dispatch of guard forces, etc.

The close approach area will typically be located between 5-50 feet from the perimeter of the secure area and the sterile area will be approximately 5-10
10 feet wide depending on the specific characteristics of the secure area. The zone segments may vary from 75 to 1,000 feet.

The SMD sensors used in Figures 4 and 5 are structural moment detectors (SMD's), for example,
15 of the prior art form shown in Figure 1. These sensors can alternatively be implemented by means of "structural information detectors" in which raw data from a structural moment detector is converted and processed within a unitary device
20 (including the SMD) such that the signal output from the device has a directly useful information content.

Fig. 6 is a block diagram illustrating the major sub-components of a structural
25 information detector suitable for use in the systems described hereinbefore. The structural information detector, generally indicated by the reference numeral 410, is depicted for purposes of illustration as being mounted upon a simple

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cantilevered beam 411 and consists of a housing 412, an optical sensor 413, sensor power supply 414, raw signal conversion circuitry 414c and signal-processing electronics, including a microprocessor and appropriate software 415. The optical sensor 413, for example, a structural moment detector of the type generally disclosed in U.S. patent 4,287,511 (sometimes also known as a "flexural rigidity sensor") measures, as indicated by the dashed line 413a, the relative orientation of surface coordinate vectors which are, as illustratively depicted in Fig. 6, normals 416 to the surface 411a of the beam 411. If a force F (417) is applied in the direction of the arrow 417a to the beam 411, resultant bending of the beam 411 will cause a change in the relative orientation of the surface coordinate vectors 416 to the positions indicated by the dashed lines 416a, i.e., from the angular orientation 418 θ_1 (shown in Fig. 6, illustratively, as 180°) to an angular orientation 418a θ_2 which (as illustratively depicted in Fig. 6) is greater than θ_1 . Power 419 from an external power source 419a is supplied to the circuitry 414 which, as explained below, provides a regulated power supply 414a to the optical sensor 413. The raw data 413b from the optical sensor 413, which could be a variable voltage or a variable current, is supplied to the raw signal conversion portion of the circuitry 414, which converts the raw data, as will be further explained below, to a form which is the input 414b to the signal and data-processing electronics and software 415, which processes the converted signal 414b and provides, as the output 415a of the structural information detector 410, a signal which embodies useful structural information 420 which directly indicates the effect of the force F acting on the beam 411. As

indicated by the line 420a, the useful structural information 420 can be utilised in any or all of a variety of ways, i.e., it can be used as the input to a direct display 520b which may be a
5 simple galvanometric meter, liquid crystal display, light emitting diode display, cathode ray tube or the like. Also or alternatively, the useful structural information 420 can be used as the input to a semi-permanent or permanent recording
10 device 420c, such as a paper recorder, magnetic recorder, semiconductor storage device, bubble memory storage device, or holographic storage device. Also or alternatively, the useful structural information 420 can form the input
15 to various control devices 420d such as servomotors and other similar electromechanical devices.

As will be appreciated by those skilled in the art, it may be desirable to provide communication paths between some or all of the individual
20 structural information detectors in a detector array and/or with suitable central data display, recording and/or control components, as well as with additional hardware and software which correlate the useful structural information outputs of the
25 individual structural moment detectors in the array. These details have been omitted for the purpose of clarity.

The raw data output 413b of the optical sensor 413 is (referring to Fig. 7) the input to the signal
30 processing electronics, including computational software therein depicted. The function of the circuitry depicted in Fig. 7 is to convert the raw data input 413b from the optical sensor into data suitable for electronic data processing and then to perform the data-processing

function to yield a signal, the components of which directly provide useful structural information. According to the presently preferred embodiment of the structural information detector, the conversion is performed with analog electronics, rather than digital. The analog electronics perform two distinct functions. First, the output signal 413b from the optical sensor is measured and converted to a proportional voltage in a voltage follower circuit which, for clarity of illustration, are those components which are located within the dashed line 421. The second function is to amplify the proportional voltage signal from the voltage follower circuit 421 by feeding it through a gain control 422 into an amplifier which, for purposes of clarity of description, are those components located within the dashed line 423. The voltage follower circuit 421 operates as a short circuit load for the photovoltaic cells of the optical sensor. Feedback is added in the amplifier circuit 423 to shape the upper end of the frequency response so that spurious high frequency noise is attenuated. This function is performed by applying the output of IC1 (pin 7) to the input (pin 6) of IC2 through a voltage divider formed by R7-R8. IC2 acts as a low-pass filter. The output of IC2 (pin 7) is fed back through R16 to the input 3 of IC1 to act as an automatic bias adjustment. An offset voltage adjustment is provided to remove any bias due to photocell mismatch.

The gain control 422 provides a means of balancing the mechanical gain of different sensors and compensating for components variation. The nominal adjustment range is $\pm 15\%$. The amplifier 423 is a high gain direct-coupled amplifier with feedback to further attenuate high frequency noise levels. Nominal gain is 1.5 volts/microamp and the bandwidth is normally initially set at 50-500 Hz. In essence, A2 is a variable cut-off

low-pass filter. If the DC case is considered, its output will seek a level such that the voltage presented to pin 3 of A1 is equal to that presented to pin 2 by the voltage follower circuit. The scaling of the system is such that

$$U_{null} = V_{int} (R17/R16+R17) = V_{in}$$

where V_{int} is the integrator output, V_{in} is the first stage and U_{null} is the input to A1, pin 2. Thus, for low frequency, V_{int} represents a scaled value equal to or greater than V_{in} independent of the gain in the second stage of the amplifier. The implication of this is that the gain of the second stage can be set very high for frequencies above the autounum roll-off without completely losing DC information.

Support and bias circuits which include the components which are, for clarity of illustration, enclosed within the dashed line 424 are provided to provide conditioned power and bias voltages for the components of the voltage follower 421 and amplifier 423.

The output 426 of the amplifier 423 is an analog signal which is converted to a digital signal in the A-D converter 422a. A non-limiting, illustrative, example of a suitable analog-digital converter is manufactured by the U.S. firm Analog Devices under number HAS1202.

The signal-processing electronics also includes a microprocessor 425 and appropriate computational software which converts the output signal 422b of the A-D converter 422a into electrical signals 420 which directly provide data related to the effect of the force acting on the structure to which the structural information detector is attached. In the presently preferred embodiment, this component



includes a microprocessor, the necessary supporting devices and a power supply, details of which are omitted for purposes of clarity because they are well-known to those skilled in the art. Suitable
5 non-limiting examples of microprocessors which can be employed are the TI9000 or the Intel 8086.

All of the elements described in Figs. 7 and 8 may be fabricated on a printed circuit board using standard integrated circuits or on a single thick
10 film substrate where the circuits have been wire bonded to the substrate. In the embodiment of the detector described in connection with Fig. 10, these components may be made as a single integrated circuit on the same semiconductor substrate chip used in fabricating
15 the optical sensor.

Another function of the signal-processing electronics is to provide a precise current to the light emitting diode of the optical sensor.

Typical non-limiting, illustrative, values of the
20 components of Fig. 7 are set forth below:

Voltage Follower/Amplifier

R1 - 220K
R5 - 1K
R6 - 2.2K
25 R9 - 2.2M
R23 - 82
A1 - Operational Amplifier LF353/2

Second Stage Amplifier

P2 - 680K
30 R3 - 10K
R4 - 1M
R7 - 100K
R8 - 10K

R13 - 2.2M
 R15 - 220K
 R16 - 10K
 R17 - 1K
 C2 - 47PF
 C3 - 10MF
 C4 - 5PF
 A1 - Operational Amplifier LF 353/2
 A2 - Operational Amplifier LF 353/2

5

10

Support and Bias Circuits

R10 - 100K
 R11 - 1.8K
 R12 - 100K
 R14 - 1.8K
 C5 - 10MF
 C6 - 10MF
 C7 - 10MF
 C8 - 10MF
 Z1 - LM336
 Z2 - LM336

15

20

For the sake of clarity, the power supply circuitry has been separated from the circuitry of Fig.7 and is shown schematically in Fig. 8. The 15 volt power supply 431 is provided by the support and bias circuitry 424 of Fig. 7.

25

The power supply circuitry of Fig. 8 utilises two amplifiers in a high gain feedback arrangement to provide the necessary precise current 432 to the light emitting diode.

30

Typical non-limiting, illustrative, values of the components of Fig.8 are set forth below:

Power Supply

R18 - 3.3K
R19 - 10K
R20 - 10K
5 R21 - 10K
R22 - 47
C9 - 10MF
C10 - 10MF
IC3 - Operational Amplifier LF353/2
10 Q1 - 2N5457
Q2 - TIP21

Fig. 9 is a sectional view illustrating a particular form of structural information detector which consists of a first housing sub-assembly generally indicated by reference character 440 containing the sensor power supply/raw signal conversion/ signal-processing electronics 441 of Figs. 7 and 8 , a light emitting diode 442, a pair of photovoltaic detectors 443 and a collimating lens 444 carried proximate the open end of a barrel portion 445 formed in the housing 440. A second housing sub-assembly, generally indicated by reference numeral 446, carries a plane surface mirror 447 on the inner end 448 of a mating barrel portion 449 formed in the housing sub-assembly 446. Although a substantial clearance 450 is shown between the barrel portion 445 formed in the first housing sub-assembly 40 and the barrel portion 449 formed in the second housing sub-assembly 446, it will be understood by those skilled in the art that this clearance is shown only for the purpose of clarifying the mechanical relationship of the two housing sub-assemblies 440 and 446. In actuality, the mating barrel portion 449 formed in the second housing sub-assembly 446 is shaped and dimensioned to receive the barrel portion 445 formed in the first housing sub-assembly 440 with an interference

fit therebetween, to form a unitary structurally integrated device which excludes ambient light from the interior of the barrel portions 445 and 449 and which facilitates and assists in maintaining precise optical alignment of the two sub-assemblies.

Structural information detectors of the type depicted in Fig. 9 have been successfully manufactured and tested which are in the size range of as small as one inch in the major dimension. Present work indicates that, eventually, this can be reduced to 1/4-1/8" in the major dimension.

Fig. 10 illustrates another form of structural information detector in which all of its components are carried by any suitable semiconductor substrate, such as a silicon chip 451. The generally U-shaped chip 451 carries the light emitting diode 452 on an inner face 453 of one of the legs of the U-shaped chip and leads 454 for providing power to the light emitting diode. A pair of photovoltaic cells 455 are grown by known semiconductor manufacturing techniques on the inner face 456 of the opposing leg of the U-shaped chip 451. Bending of the chip 451 induced by bending of a structural member to which it is attached by any suitable technique, such as epoxy bonding, causes a variation in the light falling on the photocells 455, depending on the relative orientation of surface coordinate vectors (normals) 456. The circuitry of Figs. 7 and 8 is formed by known semiconductor manufacturing techniques in the portion 457 of the silicon chip 451. The entire chip is then received within a suitable housing indicated by the dashed lines 458 to protect the internal components from adverse ambient environmental effects and to prevent stray light from interfering with the operation of the optical components 452 and 455. As in the case of the embodiment of Fig. 9, devices such as those depicted

in Fig. 10 can be manufactured in a size as small as 1/4-1/8" in the major dimension.

In the form of structural information detector depicted in Fig. 11, the components of the optical sensor 410 (Fig. 6) are carried by an elongate light transmission member, generally indicated by reference character 461, formed of a light-transmitting flexible material such as, for example, methacrylate polymers and copolymers known in the art. A concentrating lens 462 is formed in one end of the light-transmission member 61 and the other end 463 carries a light source 464 such as a LED and a pair of photocells 465 which generate electrical signals indicating the relative orientation of surface vector coordinates (normals) 466 to the surface of a structural member upon which the structural information detector is mounted. If desired, the length of the light-transmission path 467 can be lengthened by cutting or forming facets 468 in the external surfaces of the elongate light-transmitting member which will reflect light beams 468 transmitted from the LED to the concentrating lens 462 and which are then reflected 469 to the photocells 465. The entire optics system illustrated in Fig. 11, along with the sensor power supply/raw signal conversion/signal-processing electronics components of the structural information detector of Fig. 6, are then enclosed in a suitable housing to protect the optics and electronics components from adverse ambient conditions and from interference caused by stray light. The housing is omitted in Fig. 11 for purposes of clarity. Of course, by omission of the signal processing electronics, the Figure 11 optics system can be employed as a simple structural moment detector.



CLAIMS

1. A perimeter security system for locating and characterising the source of attempted and/or actual penetration of the security perimeter of relatively large geographical areas, characterised in that the said system comprises, in combination;
 - a) a plurality of structural moment detectors (401, 403), arranged at spaced points in ground contact to detect intrusions and activities within and near the perimeter of said area;
 - b) processing means (405) for processing said output signals to modify the information content thereof, including rejecting components of said signals indicative of the effects of extraneous seismic forces caused by other than said intrusions and/or activities; and
 - c) signal-manipulating means (405) for manipulating the processed signals output by the processing means to provide secondary signals responsive to seismic forces caused by said intrusions and/or activities.
2. A system according to Claim 1, characterised in that each said structural moment detector (401, 402, 403) and its associated processing and signal-manipulating means (405) is constituted by a respective structural information detector (410), said detector (410) comprising, in combination:
 - a) a housing (412) mounted on a ground structure,
 - b) optical means (413) within said housing (412) for detecting the relative orientation (413a) of spaced surface coordinate vectors (416a) of

said structure , and for generating primary signals (413b) in response to changes in said orientation;

- c) circuit means (414c) within said housing (412) for converting said primary signals (413b) to a form usable by signal-processing electronics; and
- d) signal-processing electronics means (415) within said housing (412), including computational software, for processing the converted primary signals (414b) to said secondary signals (415a) .

3. A system according to Claim 2, characterised in that the optical means (413), circuit means (414c), and signal-processing electronics means (415) of the structural information detector (410) are carried by a single-piece semiconductor substrate (451) received within said housing (412).

4. A system according to Claim 2, characterised in that the housing (412) of the structural information detector (410) comprises first and second housing sub-assemblies (440,446) and in that:

- a) said first housing sub-assembly (440) contains said circuit means (441), said signal-processing electronics means (441), and those components of said optical means (413) which include a light source (442), a plurality of photovoltaic detectors (443) and a collimating lens (444); the light source (442) and photovoltaic detectors (443) being carried on the inner face of a hollow barrel



portion (445) of said first housing sub-assembly (440) and said collimating lens (444) being carried proximate the open end of said barrel portion (445);

- b) said second housing sub-assembly (446) contains, as another component of said optical means (413), a plane surface mirror (447) carried on the inner end (448) of a barrel portion (449) of the second housing sub-assembly (446), the two said housing barrel portions (445, 449) being shaped and dimensioned to mate one within the other with an interference fit therebetween to form a unitary structurally-integrated device; and
- c) said first and second housing sub-assemblies (440, 446) are mountable at spaced points.

5. A system according to Claim 2, characterised in that the said optical means (410) of the structural information detector comprises:

- a) an elongate light-transmission member (461) formed of a light-transmitting flexible material and having a light-transmitting/receiving end (463) and a reflecting end;
- b) a concentrating lens (462) formed in the reflecting end of the member (461);
- c) a light source (464) carried by said light-transmitting/receiving end (463) of the member, the light source (464) being positioned such as to direct light through the member (461) toward said reflecting end;



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- d) light-receiving means (465) carried by the light-transmitting/receiving end (463) of the member, the light-receiving means (465) being arranged to receive light transmitted through said member from the light source (464) to the concentrating lens (462) and reflected thereby back through said member to the light-receiving means (465), and to generate electrical signals in response to the received light; and
- e) means for connecting the said ends of the light-transmission member (461) to spaced points on the ground such that ground movement causes corresponding bending of the light-transmission member (461) and, in turn, causes a variation in the amount of light received by the light-receiving means (465).

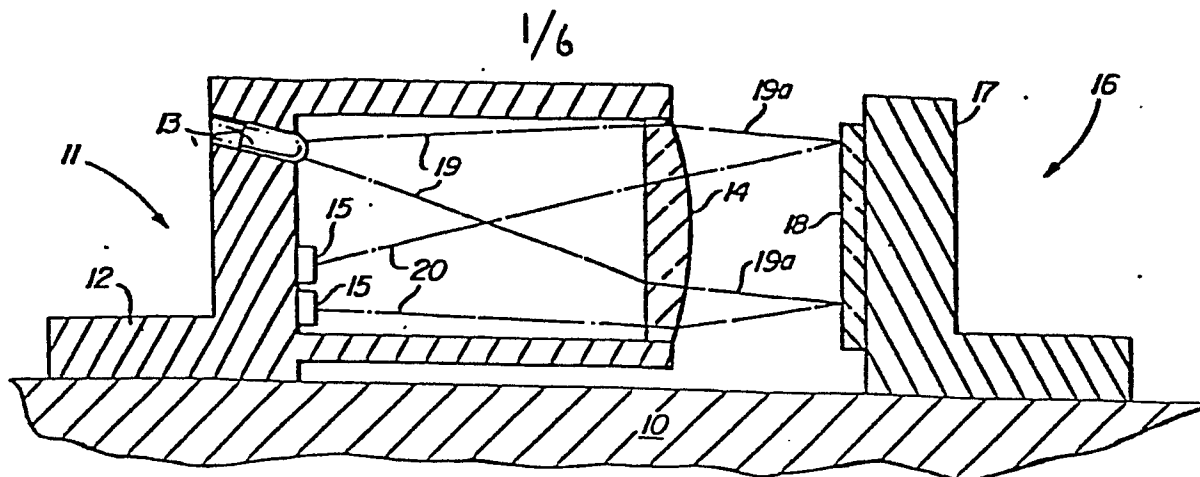
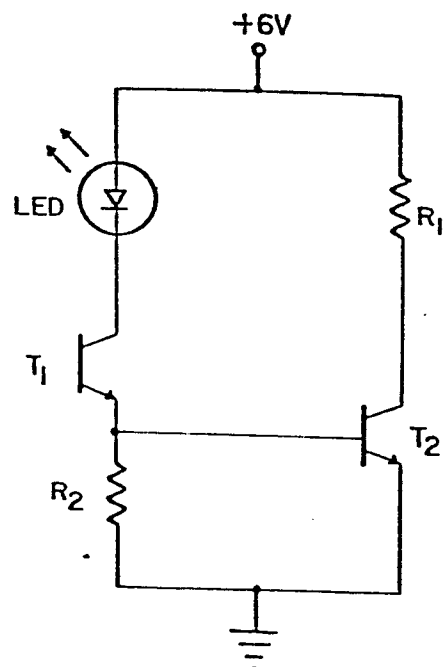
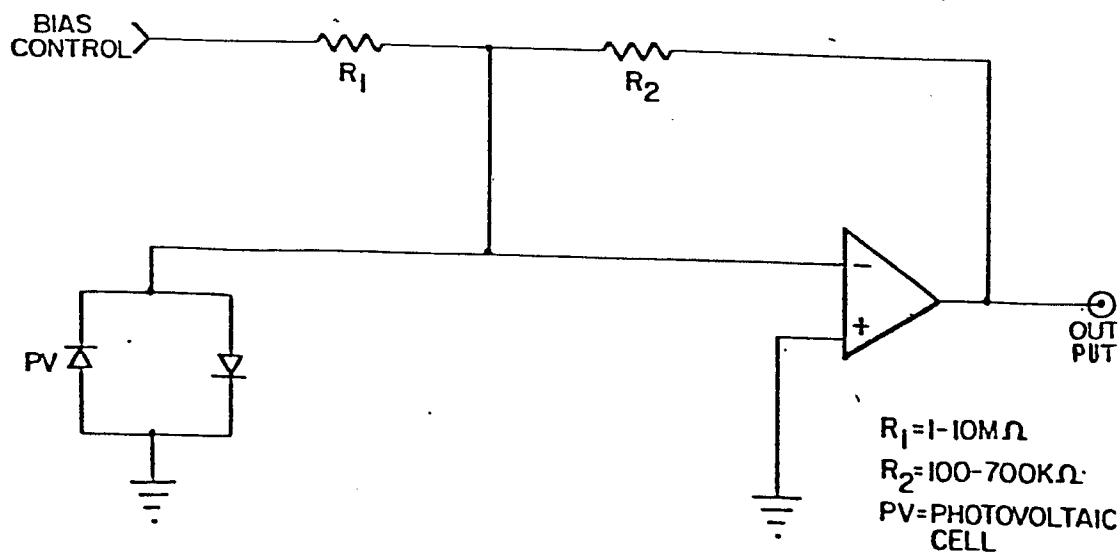


FIG-1



$R_1 = 4990 \text{ OHM}$
 $R_2 = 20 \text{ OHM}$
 $T_1 = T_2 = 2N2222$
 OR EQUIVALENT
 LED = LIGHT EMITTING DIODE

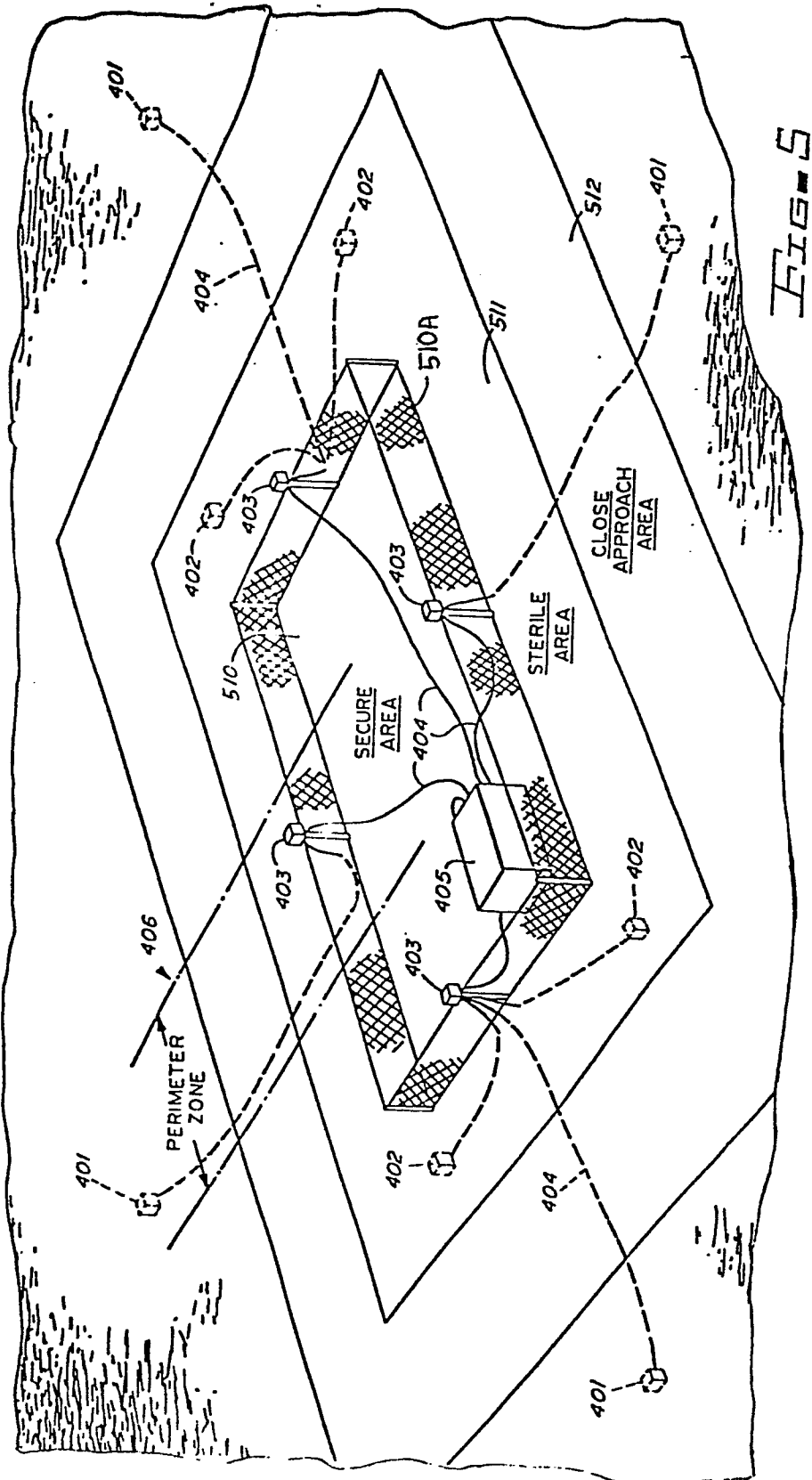
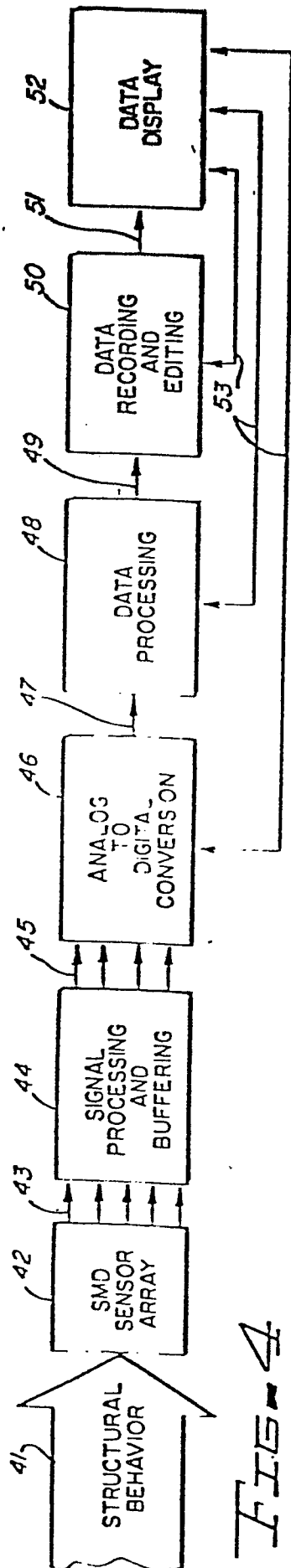
FIG-2



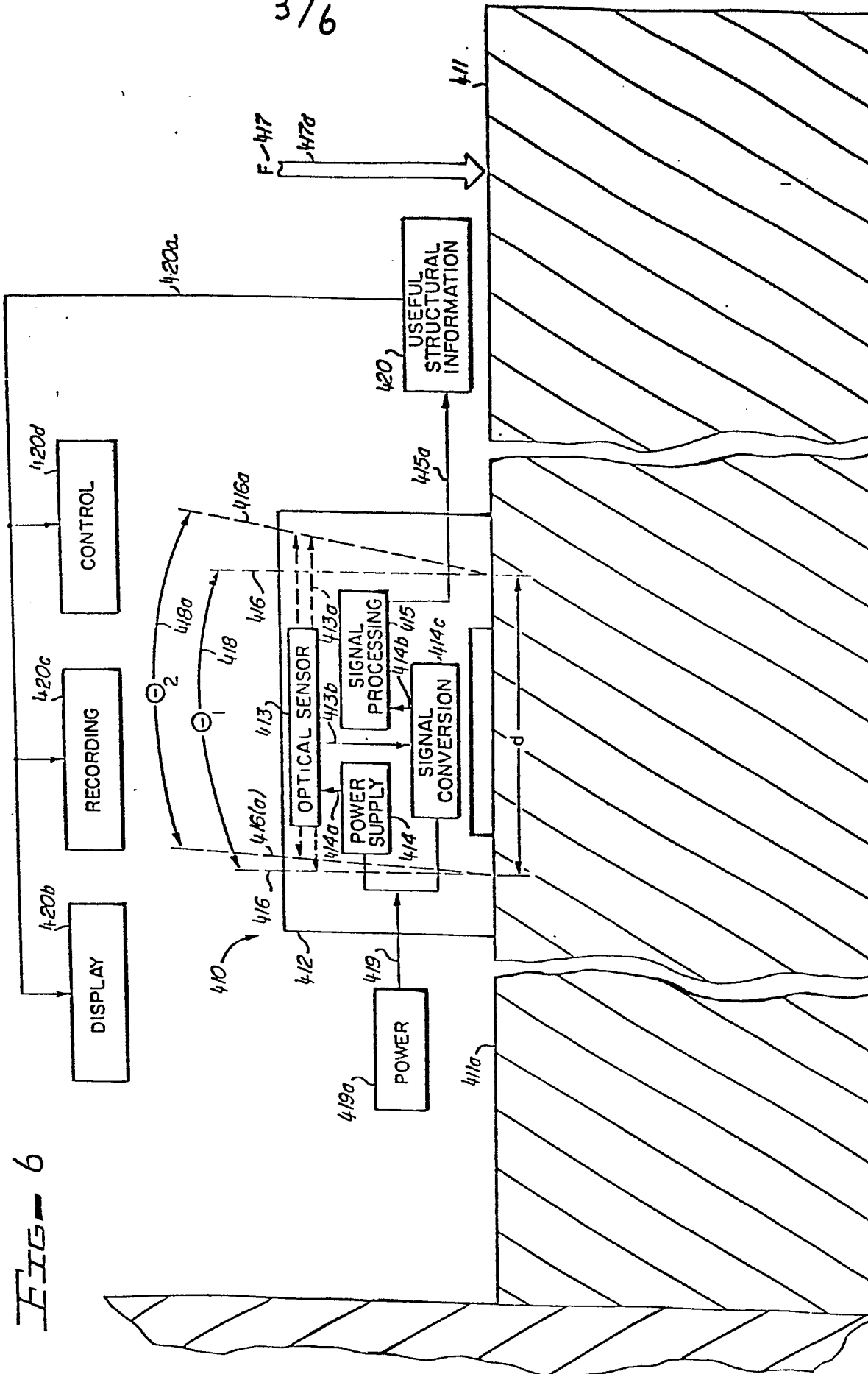
$R_1 = 1-10M\Omega$
 $R_2 = 100-700K\Omega$
 PV = PHOTOVOLTAIC CELL

FIG-3

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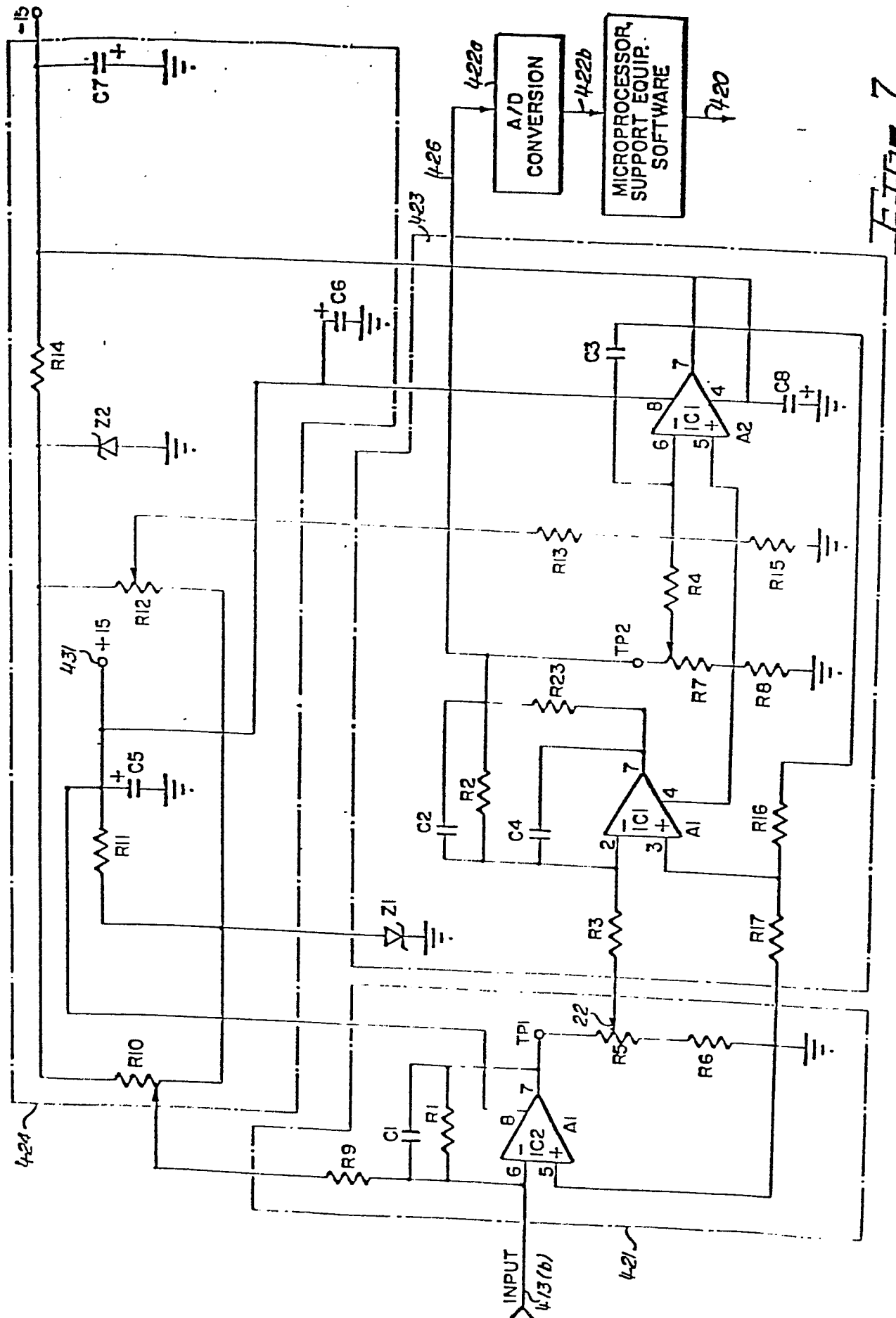
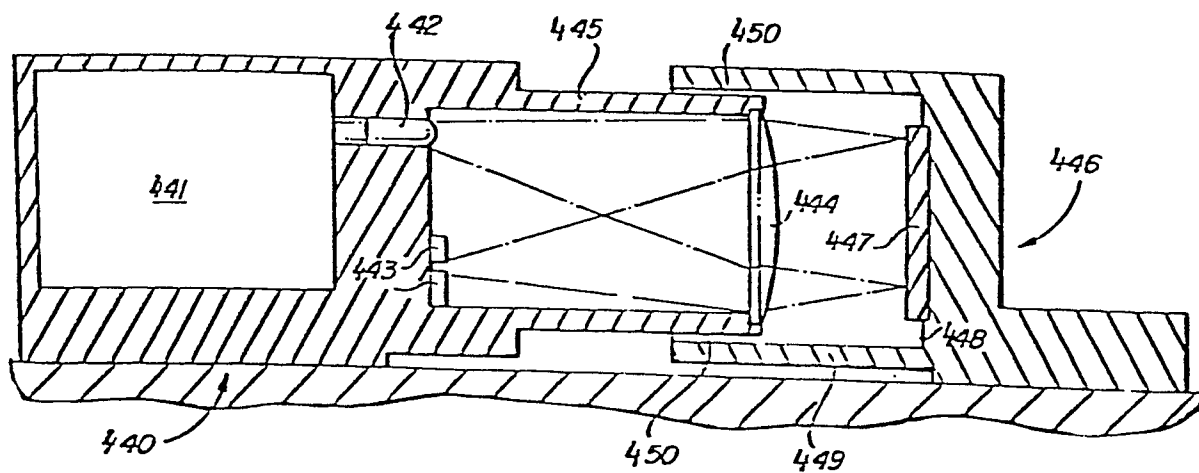
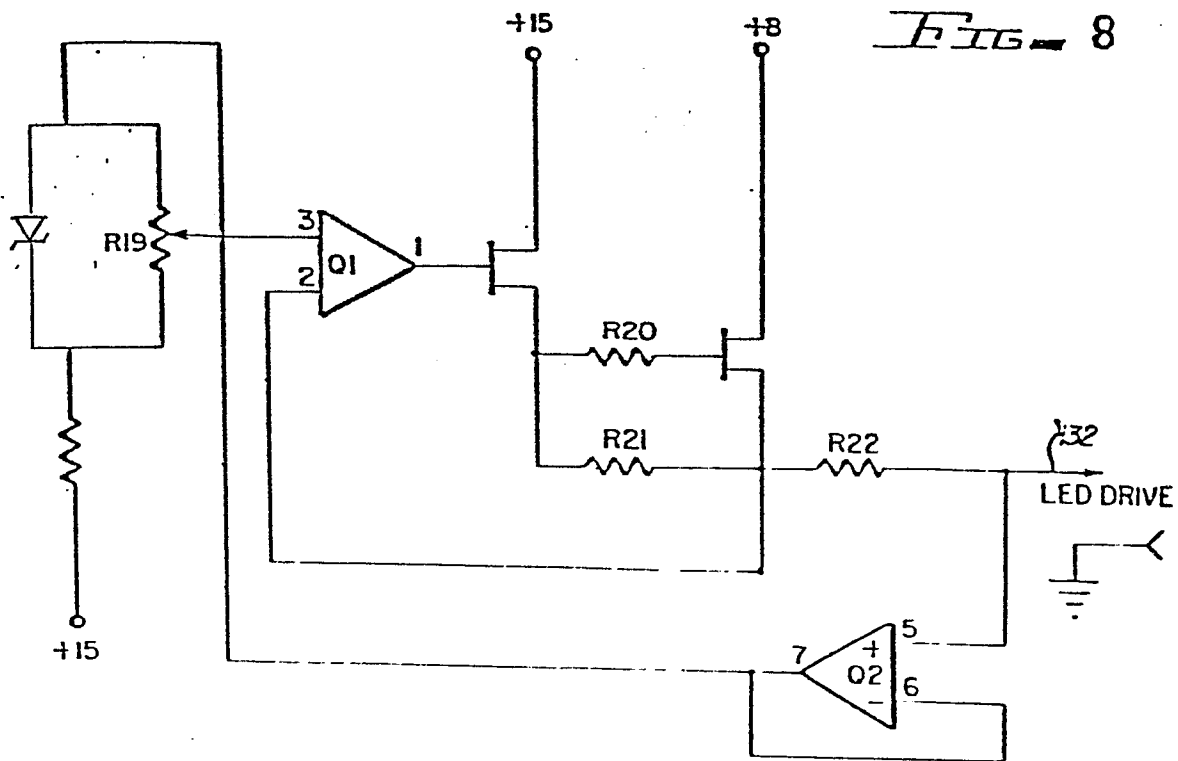


FIG 7

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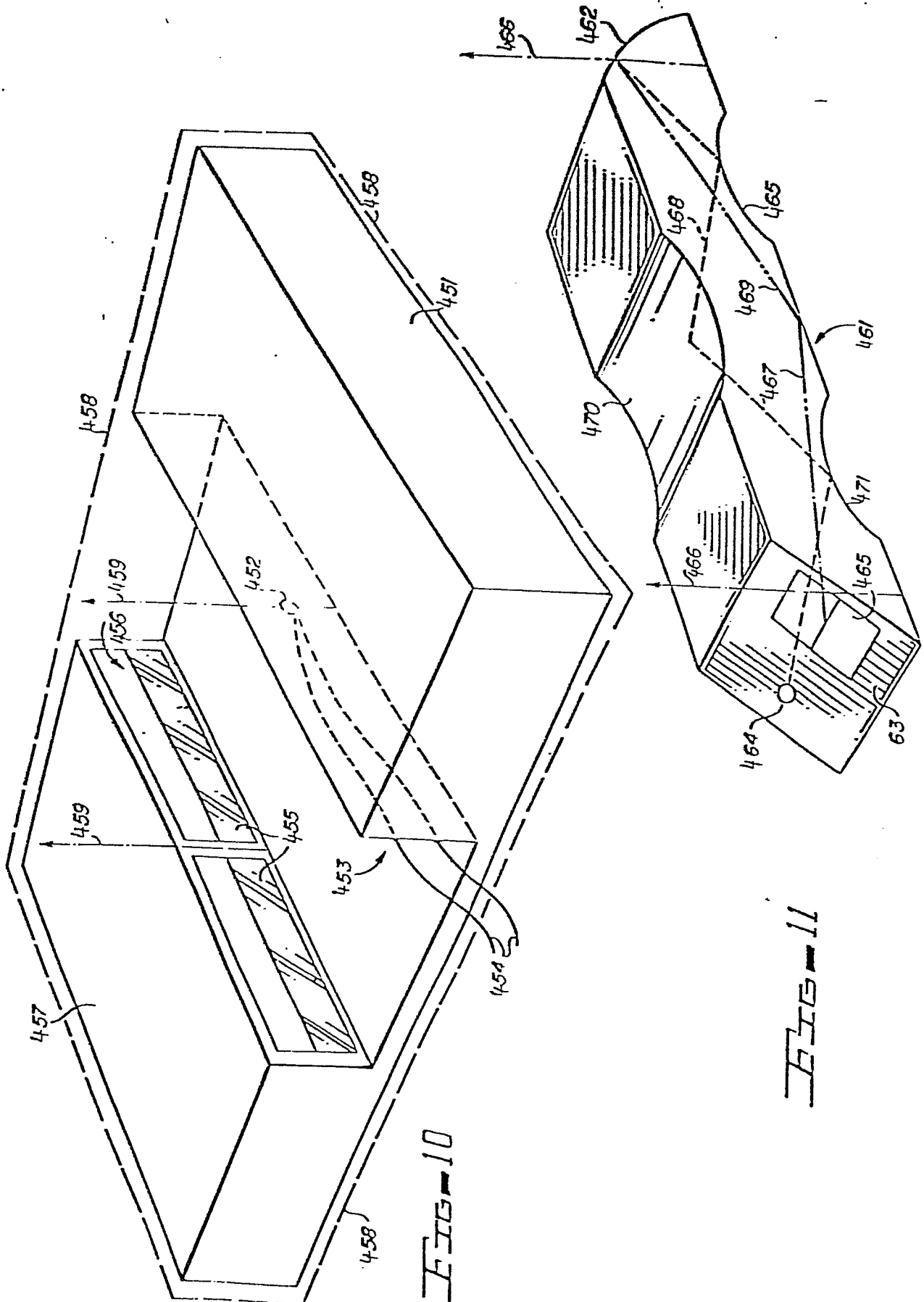


FIG. 10

FIG. 11